

TEST REPORT

APPLICANT SHENZHEN TVT DIGITAL

TECHNOLOGY CO.,LTD.

PRODUCT NAME : Face Recognition & Access Control

Terminal

MODEL NAME : TD-E2127-IC, TD-E2127-IC/TP,

TD-E2127-TP, TD-E2127

BRAND NAME: TVT

FCC ID : 2ATOW-TD-E2127

STANDARD(S) : 47 CFR Part 15 Subpart C

RECEIPT DATE : 2021-09-06

TEST DATE : 2021-09-15 to 2021-10-15

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Edited by:

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Change History						
Version	Version Date Reason for change					
1.0	2021-10-15	First edition				

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1. Technical Information

Note: Provide by applicant.

1.1. Applicant and Manufacturer Information

Applicant:	SHENZHEN TVT DIGITAL TECHNOLOGY CO.,LTD.		
	23rd Floor Building B4 Block 9, Shenzhen Bay science and		
Applicant Address:	technology ecological garden, Nanshan District, Shenzhen, P.R.		
	China		
Manufacturer:	SHENZHEN TVT DIGITAL TECHNOLOGY CO.,LTD.		
	23rd Floor Building B4 Block 9, Shenzhen Bay science and		
Manufacturer Address:	technology ecological garden, Nanshan District, Shenzhen, P.R.		
	China		

1.2. Equipment Under Test (EUT) Description

Product Name:	Face Recognition & Access Control Terminal		
Sample No.:	1#		
Hardware Version:	1.4-1422322		
Software Version:	5.0.1.0(21901)		
Operating Frequency:	13.56MHz		
Modulation Type:	ASK		

Note1:For a more detailed description, please refer to Specification or User's Manual supplied by the applicant and/or manufacturer.





1.3. Test Standards and Results

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart C for the EUT FCC ID Certification:

No	Identity	Document Title
1	47 CFR Part 15(10-1-15 Edition)	Radio Frequency Devices

Test detailed items/section required by FCC rules and results are as below:

No.	Section	Description	Test Date	Test Engineer	Result	Method Determination /Remark
1	15.203	Antenna Requirement	N/A	N/A	PASS	No deviation
2	15.207	Conducted Emission	Sep 15, 2021	Su Zhan	PASS	No deviation
3	15.209 15.225(a) (b)(c)(d)	Radiated Emission	Oct 09, 2021	Gao Jianrou	PASS	No deviation
4	15.225(e)	Frequency Tolerance	Oct 15, 2021	LiuBo	PASS	No deviation
5	15.215(c)	20dB Bandwidth	Oct 09, 2021	Gao Jianrou	PASS	No deviation

Note 1: The tests were performed according to the method of measurements prescribed in ANSI C63.10-2013. The EUT has been tested under continuous operating condition.

Note 2: Additions to, deviation, or exclusions from the method shall be judged in the "method determination" column of add, deviate or exclude from the specific method shall be explained in the "Remark" of the above table.

Note 3:When the test result is a critical value, we will use the measurement uncertainty give the judgment result based on the 95% confidence intervals.

1.4. Environmental Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature (°C):	15-35
Relative Humidity (%):	30-60
Atmospheric Pressure (kPa):	86-106





2. 47 CFR Part 15C Requirements

2.1. Antenna Requirement

2.1.1. Applicable Standard

According to FCC 15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section.

2.1.2. Test Result: Compliant

The EUT has a permanently and irreplaceable attached antenna. Please refer to the EUT internal photos.





2.2. Conducted Emission

2.2.1. Test Requirement

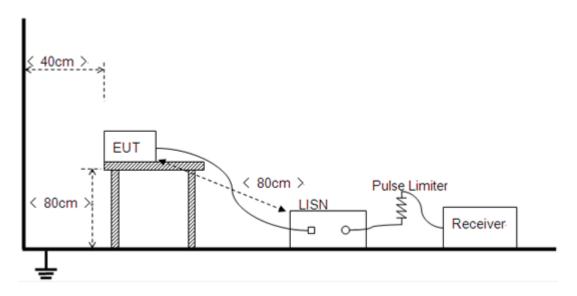
According to FCC section 15.207, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a $50\mu H/50\Omega$ line impedance stabilization network (LISN).

Fraguency Pange (MHz)	Conducted Limit (dBµV)		
Frequency Range (MHz)	Quai-peak	Average	
0.15 - 0.50	66 to 56	56 to 46	
0.50 - 5	56	46	
5 - 30	60	50	

NOTE:

- (a) The lower limit shall apply at the band edges.
- (b) The limit decreases linearly with the logarithm of the frequency in the range 0.15 0.50MHz.

2.2.2. Test Setup



The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides $50\Omega/50\mu H$ of coupling impedance for the measuring instrument. A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

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Block67, BaoAn District, ShenZhen , GuangDong Province, P. R. China



2.2.3. Test Result

REPORT No.: SZ21090018W01

The maximum conducted interference is searched using Peak (PK), if the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. Set RBW=9kHz, VBW=30kHz. Refer to recorded points and plots below.

Note: Both of the test voltage AC 120V/60Hz and AC 230V/50Hzwere considered and tested respectively, only the results of the worst case AC 120V/60Hz were recorded in this report.

A.Test Setup:

Test Mode:EUT+ADAPTER+13.56MHz TX

Test voltage: AC 120V/60Hz

The measurement results are obtained as below:

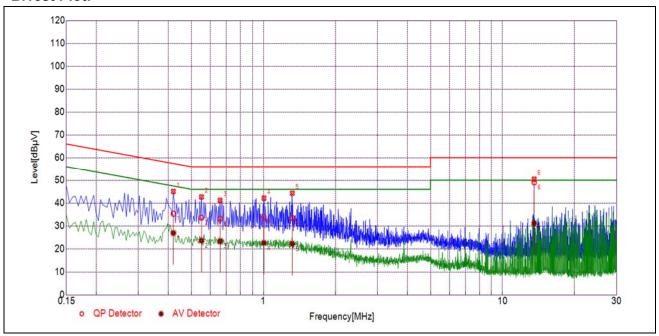
 $E [dB\mu V] = U_R + L_{Cable loss} [dB] + A_{Factor}$

U_R: Receiver Reading

A_{Factor}: Voltage division factor of LISN



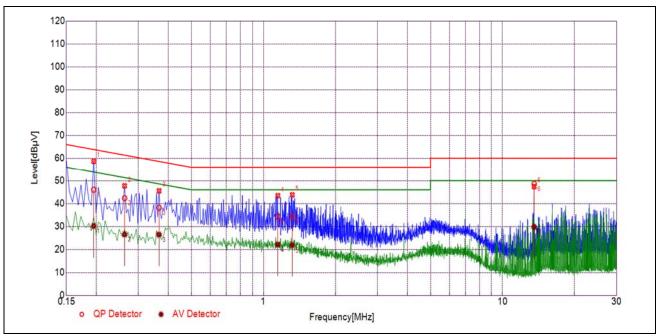
B.Test Plot:



(L Phase)

No.	Fre.	Emission Level (dBµV)		Limit (dBµV)		Power-line	Verdict
	(MHz)	Quai-peak	Average	Quai-peak	Average		
1	0.4201	35.31	26.88	57.45	47.45		PASS
2	0.5504	33.59	23.58	56.00	46.00		PASS
3	0.6588	33.15	23.32	56.00	46.00	Line	PASS
4	1.0042	33.91	22.56	56.00	46.00	Lille	PASS
5	1.3204	33.46	22.21	56.00	46.00		PASS
6	13.5603	49.04	31.17	60.00	50.00		PASS





(N Phase)

NO.	Fre.	Emission Level (dBµV)		Limit (dBμV)		Power-line	Verdict
	(MHz)	Quai-peak	Average	Quai-peak	Average		
1	0.1951	46.07	30.17	63.81	53.81		PASS
2	0.2626	42.35	26.52	61.35	51.35		PASS
3	0.3658	38.16	26.38	58.60	48.60	Noutral	PASS
4	1.1483	34.29	22.05	56.00	46.00	Neutral	PASS
5	1.3191	34.47	21.85	56.00	46.00		PASS
6	13.5601	48.61	29.73	60.00	50.00		PASS



2.3. Radiated Emission

2.3.1. Test Requirement

Radiated Emission <30MHz (9 kHz-30MHz, E-field)

According to FCC section 15.225, for <30MHz, Radiated emissions were measured according to ANSIC63.4. The EUT was set to transmit at the highest output power. The EUT was set 30 meter away from the measuring antenna. The loop antenna was positioned 1 meter above the ground from the center of the loop. The measuring bandwidth was set to 10KHz. (Note: During testing the receive antenna was rotated about its axis to maximize the emission from the EUT)

There was no detected Restricted bands and Radiated Spurious emission below 30MHz. The 30m limit was converted to 3m Limit using square factor(x) as it was found by measurements as follows; $3 \text{ m Limit}(dBuV/m) = 20\log(X)+40\log(30/3)=20\log(15848)+40\log(30/3)=124dBuV$

Except as provided elsewhere in this Subpart, the emissions from an intentional radiator shall not exceed the field strength levels specified in the following table:

Fraguency Pango (MHz)	Field Stre	Field Strength@3m	
Frequency Range (MHz)	μV/m	dBμV/m	dBμV/m
Below 13.110	30	29.5	69.5
13.110 ~ 13.410	106	40.5	80.5
13.410 ~ 13.553	334	50.5	90.5
13.553 ~13.567	15.848	84	124
13.567 ~ 13.710	334	50.5	90.5
13.710 ~14.010	106	40.5	80.5
Above 14.010	30	29.5	69.5

NOTE:a) Field Strength ($dB\mu V/m$) = 20*log[Field Strength ($\mu V/m$)].

b) In the emission tables above, the tighter limit applies at the band edges.

Radiated Emission >30MHz (30MHz-1GHz, E-field)

According to FCC section 15.205, the field strength of radiated emissions from intentional radiators at a distance of 3 meters shall not exceed the following values:

	•	
Fraguency Bongo (MUz)	Field S	trength
Frequency Range (MHz)	μV/m	dBμV/m
30 - 88	100	40
88 - 216	150	43.5
216 - 960	200	46
Above 960	500	54

NOTE:a) Field Strength ($dB\mu V/m$) = 20*log[Field Strength ($\mu V/m$)].

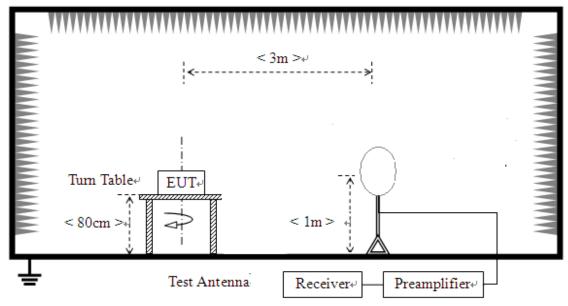
b) In the emission tables above, the tighter limit applies at the band edges.



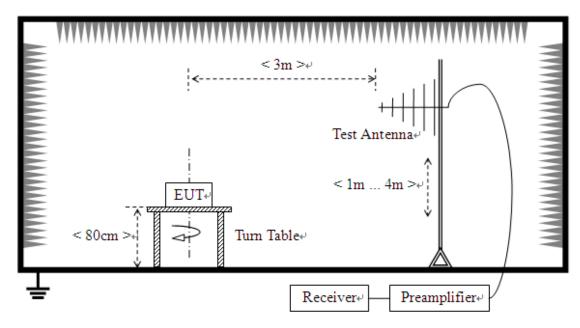


2.3.2. Test Setup

1) For radiated emissions below 30MHz



2) For radiated emissions from 30MHz to1GHz



The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on a variable-height antenna master tower.



For the test Antenna:

In the frequency range of 9 kHz to 30MHz, magnetic field is measured with Loop Test Antenna. The Test Antenna is positioned with its plane vertical at 1m distance from the EUT. The center of the Loop Test Antenna is 1m above the ground. During the measurement the Loop Test Antenna rotates about its vertical axis for maximum response at each azimuth about the EUT.

In the frequency range above 30MHz, Bi-Log Test Antenna (30MHz to 1GHz) was used. Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength. The emission levels at both horizontal and vertical polarizations should be tested.

For measurements frequency range from 0.009MHz to 0.15MHz, the resolution bandwidth is set to 200kHz.

For measurements frequency range from 0.15MHz to 30MHz the resolution bandwidth is set to 9kHz.

The emission limits shown in the above are based on measurements employing a CISPR quasi-p eak detector except for the frequency bands 9-90 kHz and 110-490 kHz. Radiated emission limits in these three bands are based on measurements employing an average detector.

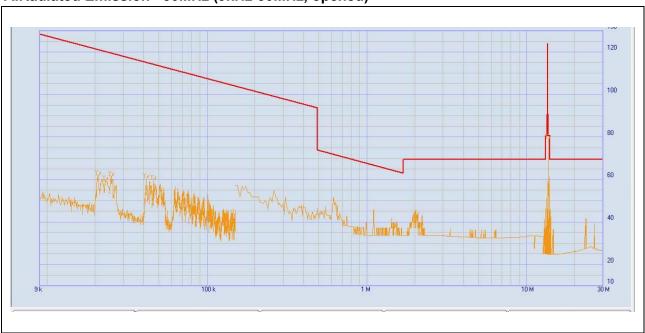
For measurements below 1GHz the resolution bandwidth is set to 120 kHz for peak detection measurements or 120kHz for quasi-peak detection measurements. Peak detection is used unless otherwise noted as quasi-peak.





2.3.3. Test Result

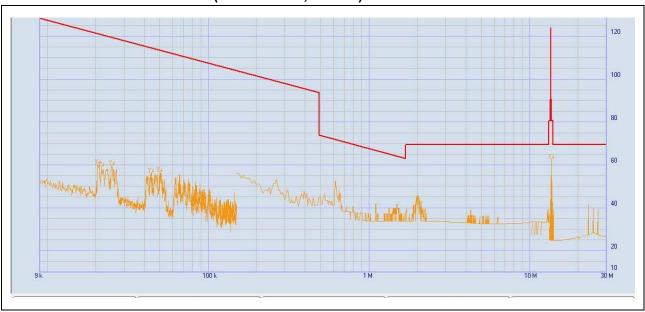
A.Radiated Emission <30MHz (9kHz-30MHz, opened)



No.	Frequency(MHz)	Detector Type	Level at 3m(dBμV/m)	Limit at 3m(dBμV/m)
1	0.0208	Quasi Peak	61.87	69.5
2	0.0231	Quasi Peak	59.62	69.5
3	0.0251	Quasi Peak	61.48	69.5
4	0.0415	Quasi Peak	60.58	69.5
5	0.046	Quasi Peak	59.82	69.5
6	13.555	Quasi Peak	79.10	124.0



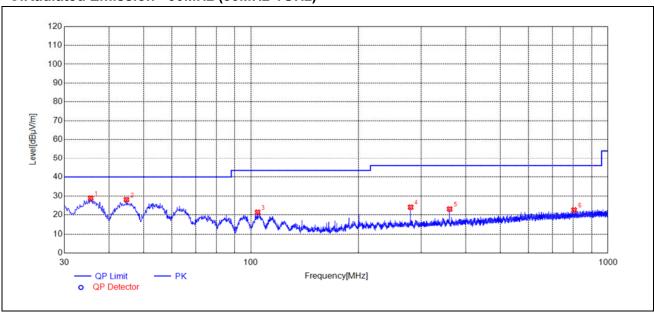
B.Radiated Emission <30MHz (9kHz-30MHz, closed)



No.	Frequency(MHz)	Detector Type	Level at 3m(dBμV/m)	Limit at 3m(dBμV/m)
1	0.0206	Quasi Peak	60.17	69.5
2	0.0216	Quasi Peak	59.12	69.5
3	0.0251	Quasi Peak	59.71	69.5
4	0.0441	Quasi Peak	56.23	69.5
5	0.0498	Quasi Peak	56.65	69.5
6	13.55	Quasi Peak	62.75	124.0



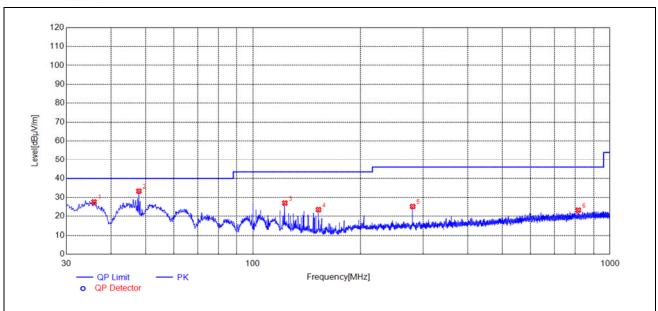
C.Radiated Emission >30MHz (30MHz-1GHz)



(30MHz - 1GHz, Test Antenna Horizontal)

Na	Fre.	Pk	QP	AV	Limit-PK	Limit-QP	Limit-AV	ANIT	\/andiat
No.	MHz	dBµV/m	dBµV/m	dBµV/m	dBµV/m	dBµV/m	dBµV/m	ANT	Verdict
1	35.5296	28.79	N/A	N/A	N/A	40.00	N/A	Η	PASS
2	44.7455	28.04	N/A	N/A	N/A	40.00	N/A	Н	PASS
3	104.3094	21.36	N/A	N/A	N/A	43.50	N/A	Н	PASS
4	279.9940	24.05	N/A	N/A	N/A	46.00	N/A	Н	PASS
5	360.0270	23.06	N/A	N/A	N/A	46.00	N/A	Η	PASS
6	803.7494	22.60	N/A	N/A	N/A	46.00	N/A	Н	PASS





(30MHz - 1GHz, Test Antenna Vertical)

Na	Fre.	Pk	QP	AV	Limit-PK	Limit-QP	Limit-AV	ANIT	\/a = di a t
No.	MHz	dBµV/m	dBµV/m	dBµV/m	dBµV/m	dBµV/m	dBµV/m	ANT	Verdict
1	35.8206	27.55	N/A	N/A	N/A	40.00	N/A	V	PASS
2	47.8498	33.25	N/A	N/A	N/A	40.00	N/A	V	PASS
3	122.7413	26.96	N/A	N/A	N/A	43.50	N/A	V	PASS
4	152.5233	23.47	N/A	N/A	N/A	43.50	N/A	V	PASS
5	279.9940	25.13	N/A	N/A	N/A	46.00	N/A	V	PASS
6	815.4875	23.23	N/A	N/A	N/A	46.00	N/A	V	PASS

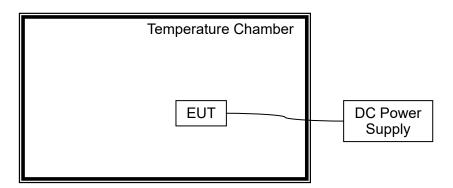


2.4. Frequency Tolerance

2.4.1. Test Requirement

According to FCC section 15.225, the devices operating in the 13.553~13.567 MHz shall maintain the carrier frequency within 0.01% of the operating frequency over the temperature variation of -20°C to +50°C using an environmental chamber. The primary supply voltage is varied from 85% to 115% of the voltage normally at the input to the device or at the power supply terminals if cables are not normally supplied.

2.4.2. Test Setup



The EUT, which is powered by the DC Power Supply directly, is located in the Temperature Chamber. The EUT was measured by transmitter mode continuously.

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2.4.3. Test Result

Operating Frequency: 13,560,000 Hz

Deference Voltage: 12.0V Deviant Limit: ±0.01%

	Test Conditions				
VOLTAGE(%)	Power	Temperature	Fre. Dev. (Hz)	Deviation(%)	Verdict
	(VDC)	(°C)			
100		-20	1000	0.00737	
100		-10	1001	0.00738	
100		0	999	0.00737	
100		+10	1000	0.00737	
100	12.0	+20	1000	0.00737	
100		+25	989	0.00729	PASS
100		+30	988	0.00729	
100		+40	1000	0.00737	
100		+50	1010	0.00745	
85	10.2	+20	1011	0.00746	
115	13.8	+20	1002	0.00739	

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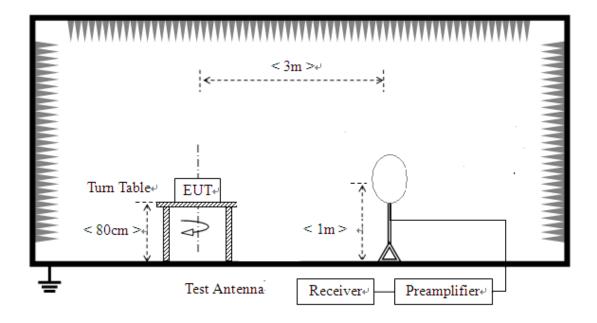


2.5. 20dB Bandwidth

2.5.1. Standard Applicable

According to FCC section 15.215(c), the 20dB bandwidth should be contained within the frequency band designated in the rule section under which the EUT is operated, it was measured with a spectrum analyzer connected the EUT while the EUT is operating in transmission mode.

2.5.2. Test Setup







2.5.3. Test Result

	Me	easurement			
Centre Frequency	20dB Bandwidth	Frequency Range(MHz)	20dB Bandwidth	Frequency Range(MHz)	Verdict
	(kHz)		(kHz)	· ······9 - (····· ·=/	
13.56MHz	0.95	13.55991 to 13.56086	14	13.553 to 13.567	PASS





Annex A Test Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Radiated Emission:	±3.1dB
Conducted Emission:	±1.8dB
Bandwidth	±5%
Frequency Tolerance	±5%





Annex B Testing Laboratory Information

1. Identification of the Responsible Testing Laboratory

Laboratory Name: Shenzhen Morlab Communications Technology Co., Ltd.			
	FL.3, Building A, FeiYang Science Park, No.8 LongChang		
Laboratory Address:	Road, Block 67, BaoAn District, ShenZhen, GuangDong		
	Province, P. R. China		
Telephone:	+86 755 36698555		
Facsimile:	+86 755 36698525		

2. Identification of the Responsible Testing Location

ShenzhenMorlab Communications Technology Co., Ltd.

FL1-3, Building A, FeiYang Science Park, No.8 LongChang Road,

Block67, BaoAn District, ShenZhen , GuangDong Province, P. R. China

Name:	Shenzhen Morlab Communications Technology Co., Ltd.
	FL.3, Building A, FeiYang Science Park, No.8 LongChang
Address:	Road, Block 67, BaoAn District, ShenZhen, GuangDong
	Province, P. R. China

3. Facilities and Accreditations

All measurement facilities used to collect the measurement data are located at FL.3, Building A, FeiYang Science Park, Block 67, BaoAn District, Shenzhen, 518101 P. R. China. The test site is constructed in conformance with the requirements of ANSI C63.10-2013and CISPR Publication 22; the FCC designation number is CN1192,the test firm registration number is 226174.





4. Test Equipments Utilized

4.1 Test Equipments

Equipment Name	Serial No.	Type	Manufacturer	Cal. Date	Due Date
Receiver	MY54130016	N9038A	Agilent	2021.07.16	2022.07.15
Test Antenna - Bi-Log	9163-519	VULB 9163	Schwarzbeck	2019.05.24	2022.05.23
Test Antenna - Loop	1520-022	FMZB1519	Schwarzbeck	2019.02.14	2022.02.13
Anechoic Chamber	N/A	9m*6m*6m	CRT	2020.01.06	2023.01.05
DC Power Supply	1709D361010	IV3610	IVYTECH	2020.10.26	2021.10.25
Temperature Chamber	12108015	DTL-003S101	YOMA	2020.10.26	2021.10.25

4.2 Conducted Emission Test Equipments

Equipment Name	Serial No.	Туре	Manufacturer	Cal. Date	Due Date
Receiver	MY56400093	N9038A	KEYSIGHT	2021.03.09	2022.03.08
LISN	812744	NSLK 8127	Schwarzbeck	2021.03.09	2022.03.08
Pulse Limiter	VTSD 9561	VTSD	Schwarzbeck	2021.07.21	2022.07.20
(10dB)	F-B #206	9561-F	Conwarzbook	2021.07.21	2022:07:20
Coaxial					
Cable(BNC)	CB01	EMC01	Morlab	N/A	N/A
(30MHz-26GHz)					
Dell Computer	N/A	Vostro 5370	Made in China	N/A	N/A
			Lite-On		
Dell Adapter	N/A	LA45NM140	Technology Co.,	N/A	N/A
			Ltd.		

4.3Test Software Utilized

Model	Version Number	Manufacturer
TS+ -[JS32-RE]	Version 2.5.0.6	Tonscend
TS+ -[JS32-CE]	Version 2.5.0.0	Tonscend
PMM Emission Suite	Version 2.02	narda

END OF REPORT	

